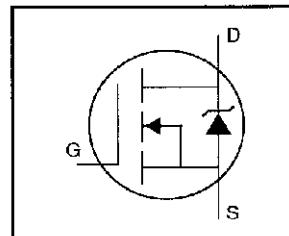


IRF1620GPbF

HEXFET® Power MOSFET

- Isolated Package
- High Voltage Isolation = 2.5kVRMS ⑤
- Sink to Lead Creepage Dist.= 4.8mm
- Dynamic dv/dt Rating
- Low Thermal Resistance
- Lead-Free

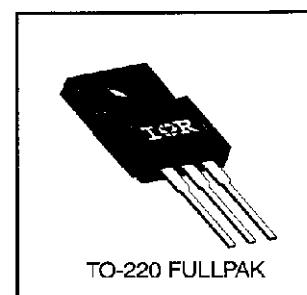


$V_{DSS} = 200V$
 $R_{DS(on)} = 0.80\Omega$
 $I_D = 4.1A$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.



Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_c = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	4.1	
$I_D @ T_c = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	2.6	A
I_{DM}	Pulsed Drain Current ①	16	
$P_D @ T_c = 25^\circ C$	Power Dissipation	30	W
	Linear Derating Factor	0.24	W/ $^\circ C$
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy ②	100	mJ
I_{AR}	Avalanche Current ①	4.1	A
E_{AR}	Repetitive Avalanche Energy ①	3.0	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
T_J	Operating Junction and	-55 to +150	$^\circ C$
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf-in (1.1 N·m)	

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
R_{JC}	Junction-to-Case	—	—	4.1	$^\circ C/W$
R_{JA}	Junction-to-Ambient	—	—	65	

IRFI620GPbF

International
Rectifier

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	200	—	—	V	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.29	—	V/ $^{\circ}\text{C}$	Reference to 25°C , $I_D=1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.80	Ω	$V_{\text{GS}}=10\text{V}$, $I_D=2.5\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{\text{DS}}=V_{\text{GS}}$, $I_D=250\mu\text{A}$
g_{fs}	Forward Transconductance	1.5	—	—	S	$V_{\text{DS}}=50\text{V}$, $I_D=2.5\text{A}$ ④
I_{DS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{\text{DS}}=200\text{V}$, $V_{\text{GS}}=0\text{V}$
		—	—	250	μA	$V_{\text{DS}}=160\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}}=20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100	nA	$V_{\text{GS}}=-20\text{V}$
Q_g	Total Gate Charge	—	—	14	nC	$I_D=4.8\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	3.0	nC	$V_{\text{DS}}=160\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	7.9	nC	$V_{\text{GS}}=10\text{V}$ See Fig. 6 and 13 ④
$t_{\text{d(on)}}$	Turn-On Delay Time	—	7.2	—	ns	$V_{\text{DD}}=100\text{V}$
t_r	Rise Time	—	22	—	ns	$I_D=4.8\text{A}$
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	19	—	ns	$R_G=18\Omega$
t_f	Fall Time	—	13	—	ns	$R_D=20\Omega$ See Figure 10 ④
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—	nH	
C_{iss}	Input Capacitance	—	260	—	pF	$V_{\text{GS}}=0\text{V}$
C_{oss}	Output Capacitance	—	100	—	pF	$V_{\text{DS}}=25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	30	—	—	$f=1.0\text{MHz}$ See Figure 5
C	Drain to Sink Capacitance	—	12	—	pF	$f=1.0\text{MHz}$

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	4.1	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ①	—	—	16	A	
V_{SD}	Diode Forward Voltage	—	—	1.8	V	$T_J=25^\circ\text{C}$, $I_S=4.1\text{A}$, $V_{\text{GS}}=0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	150	300	ns	$T_J=25^\circ\text{C}$, $I_F=4.8\text{A}$
Q_{rr}	Reverse Recovery Charge	—	0.91	1.8	μC	$dI/dt=100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

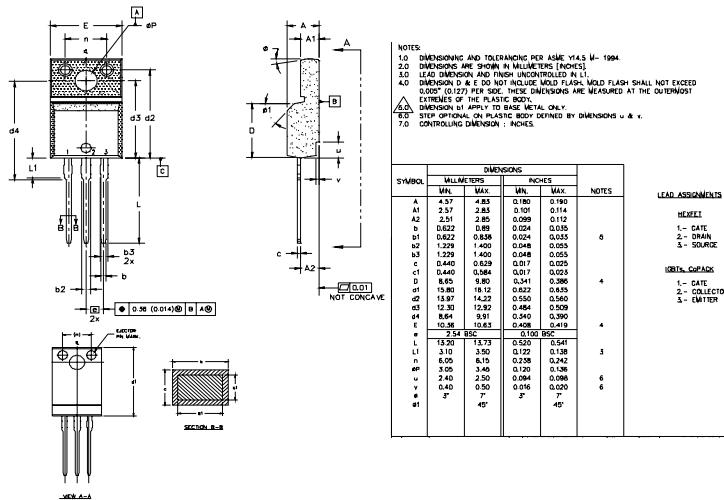
- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ③ $I_{SD} \leq 5.2\text{A}$, $dI/dt \leq 95\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 150^\circ\text{C}$
- ⑤ $t=60\text{s}$, $f=60\text{Hz}$
- ② $V_{DD}=50\text{V}$, starting $T_J=25^\circ\text{C}$, $L=8.9\text{mH}$, $R_G=25\Omega$, $I_{AS}=4.1\text{A}$ (See Figure 12)
- ④ Pulse width $\leq 300\ \mu\text{s}$; duty cycle $\leq 2\%$.

IRFI620GPbF

International
IR Rectifier

TO-220 Full-Pak Package Outline

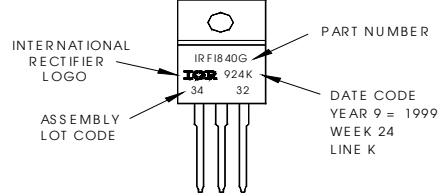
Dimensions are shown in millimeters (inches)



TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G
WITH ASSEMBLY
LOT CODE 3432
ASSEMBLED ON WW 24 1999
IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line position indicates "Lead-Free"



International
IR Rectifier